Application/Control No. Applicant(s)/Patent Under Reexamination 09/711,504 KATOH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 A. Sefer 2826 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,534,788 03-2003 Yeo et al. Α 257/72 * В US-6,414,297 07-2002 Sasaki et al. 250/214R 07-2002 С US-6,414,297 Sasaki et al. 250/214R D US-2003/0001832 01-2003 Yamazaki et al. 345/204 Ε US-F US-US-G Н US-} US-US-J K US-L US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν JP 3-145627 06-1991 Japan Oka et al 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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